CDC328 **1-LINE TO 6-LINE CLOCK DRIVER** WITH SELECTABLE POLARITY SCBS116B - JANUARY 1991 - REVISED MARCH 1994

16 1Y1

15 1T/C

14 VCC

D OR DB PACKAGE (TOP VIEW)

GND

GND П 4

2Y2 [5

GND [

3Y 🛛 6

7 4Y [8

1Y2 🛛 2

2Y1 **1**3

•	Replaces	SN74ABT328
	1.0pia000	

- Low Output Skew for Clock-Distribution and Clock-Generation Applications
- TTL-Compatible Inputs and Outputs
- Distributes One Clock Input to Six Clock Outputs
- Polarity Control Selects True or **Complementary Outputs**
- Distributed V_{CC} and GND Pins Reduce **Switching Noise**
- High-Drive Outputs (-15-mA IOH, 64-mA IOI)
- State-of-the-Art *EPIC-*II*B* ™ BiCMOS Design **Significantly Reduces Power Dissipation**
- Package Options Include Plastic Small-Outline (D) and Shrink Small-Outline (DB) Packages

description

The CDC328 contains a clock-driver circuit that distributes one input signal to six outputs with minimum skew for clock distribution. Through the use of the polarity-control inputs (\overline{T}/C), various combinations of true and complementary outputs can be obtained.

The CDC328 is characterized for operation from -40°C to 85°C.

FUNCTION TABLE								
INPU	JTS	OUTPUT						
T/C	Α	Y						
L	L	L						
L	Н	н						
н	L	н						
н	н	L						

ELINCTION TABLE

logic symbol[†]

	12	D	>	16	4.1/4
A 	15		1	2	1Y1
1T/C	13	N1	1	3	1Y2
2T/C		N2	2	5	2Y1
	10		2	6	2Y2
3T/C		N3	3		3Y
4T/C	9	N4	4	8	4Y

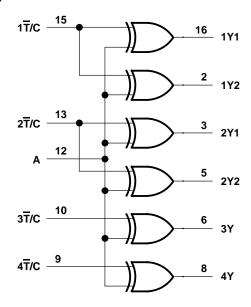
[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

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13 2T/C 12 A 11 V _{CC} 10 3T/C 9 4T/C	

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logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC} -0.5 V t Input voltage range, V _I (see Note 1) -0.5 V t Voltage range applied to approximate the high state	
Voltage range applied to any output in the high state	0 = 1 (
or power-off state, V _O (see Note 1) –0.5 V to V _{CC} +	
Current into any output in the low state, I _O 12	:8 mA
Input clamp current, I _{IK} (V _I < 0)1	8 mA
Output clamp current, I_{OK} (V _O < 0)	0 mA
Continuous total power dissipation at (or below) 25°C free-air temperature (see Note 2) 1000) mW
Storage temperature range, T _{stg} 65°C to 1	50°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

2. For operation above 25°C free-air temperature, derate to 478 mW at 85°C at the rate of 8.7 mW/°C.

recommended operating conditions (see Note 3)

		MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.75	5	5.25	V
VIH	High-level input voltage	2			V
VIL	Low-level input voltage			0.8	V
VI	Input voltage	0		VCC	V
ЮН	High-level output current			-15	mA
IOL	Low-level output current			64	mA
$\Delta t/\Delta v$	Input transition rise or fall rate			5	ns/V
fclock	Input clock frequency			80	MHz
TA	Operating free-air temperature	-40		85	°C

NOTE 3: Unused inputs must be held high or low.

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	түр†	MAX	UNIT
VIK	V _{CC} = 4.75 V,	lj = –18 mA				-1.2	V
VOH	V _{CC} = 4.75 V,	I _{OH} = – 15 mA		2.5			V
V _{OL}	V _{CC} = 4.75 V,	I _{OL} = 64 mA				0.55	V
Ц	V _{CC} = 5.25 V,	$V_I = V_{CC} \text{ or } GND$				±1	μA
10 [‡]	V _{CC} = 5.25 V,	V _O = 2.5 V		-15		-100	mA
las	V _{CC} = 5.25 V,	l _O = 0,	Outputs high			50	μA
lcc	$V_I = V_{CC}$ or GND	-	Outputs low		20	30	mA
Ci	VI = 2.5 V or 0.5 V				3		pF

[†] All typical values are at V_{CC} = 5 V, $T_A = 25^{\circ}C$

[‡]Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

switching characteristics over recommended ranges of supply voltage and operating free-air temperature (see Figures 1 and 2)

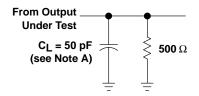
PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	ТҮР	МАХ	UNIT
^t PLH	•	Any Y	1.7		7	ns
^t PHL	A		1.5		5.4	
^t PLH	⊤/C		1.5		8	ns
^t PHL		Any Y	1.4		6.6	115
*	А	Any Y (same phase)			0.7	
^t sk(o)	~	Any Y (any phase)			2.6	ns
tr				1.2		ns
t _f				0.5		ns

switching characteristics, V_{CC} = 5 V \pm 0.25 V, T_A = 25°C to 70°C (see Figures 1 and 2)

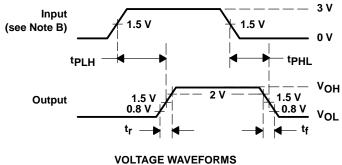
PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	МАХ	UNIT
^t PLH	A	Any Y	2.1	6.1	
^t PHL			1.7	4.8	ns
^t sk(o)	A	Any Y (same phase)		0.7	
		Any Y (any phase)		2.1	ns



PARAMETER MEASUREMENT INFORMATION



LOAD CIRCUIT FOR OUTPUTS

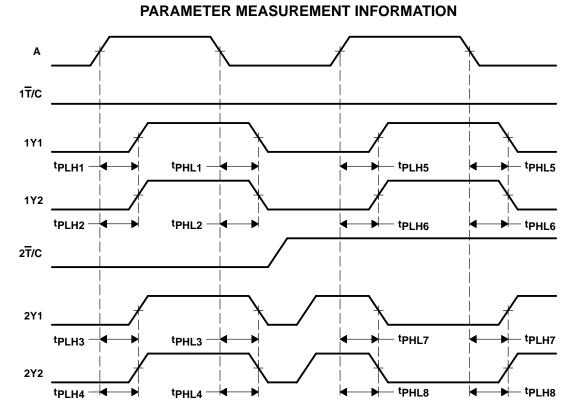


PROPAGATION DELAY TIMES

- NOTES: A. $C_{\mbox{L}}$ includes probe and jig capacitance.
 - B. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , t_f \leq 2.5 ns, t_f \leq 2.5 ns.

Figure 1. Load Circuit and Voltage Waveforms





NOTES: A. Output skew, t_{sk(o)}, from A to any Y (same phase), can be measured only between outputs for which the respective polarity-control inputs (T/C) are at the same logic level. It is calculated as the greater of:

- The difference between the fastest and slowest of tp₁ μ from A[↑] to any Y (e.g., tp₁ μ _n, n = 1 to 4; or tp₁ μ _n, n = 5 to 6)
- The difference between the fastest and slowest of tPHL from A to any Y (e.g., tPHLn, n = 1 to 4; or tPHLn, n = 5 to 6)
- The difference between the fastest and slowest of tpLH from A \downarrow to any Y (e.g., tpLHn, n = 7 to 8)
- The difference between the fastest and slowest of tpHL from A↑ to any Y (e.g., tpHLn, n = 7 to 8)
- B. Output skew, $t_{sk(0)}$, from A to any Y (any phase), can be measured between outputs for which the respective polarity-control inputs (\overline{T}/C) are at the same or different logic levels. It is calculated as the greater of:
 - The difference between the fastest and slowest of tpLH from A[↑] to any Y or tpHL from A[↑] to any Y (e.g., tpLHn, n = 1 to 4; or tpLHn, n = 5 to 6, and tpHLn, n = 7 to 8)
 - The difference between the fastest and slowest of tp_{HL} from A↓ to any Y or tp_{LH} from A↓ to any Y (e.g., tp_{HLn}, n = 1 to 4; or tp_{HLn}, n = 5 to 6, and tp_{LHn}, n = 7 to 8)

Figure 2. Waveforms for Calculation of tsk(o)



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